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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

	(219.003)	
In the Application of: YAMADA	OIA) Group Art Unit: 2829
Serial No: 09/865,528	APR 0 2 2004 8) Examiner: VINH P. NUGYEN
Filed: MAY 28, 2001	RADEMAN CH) }
Title: SEMICONDUCTOR DEV	ICE TEST METHOD)
AND SEMICONDUCTOR	DEVICE TESTER	j.

Commissioner for Patents P. O. Box 1450 Alexandria, VA 22313-1450

FEE TRANSMITTAL

Dear Sir:

Transmitted herewith is an **AMENDMENT AND RESPONSE TO DECEMBER 3, 2003 OFFICE ACTION** (14 pages + attachments).

The fee has been calculated as shown below:

		CLAIMS AS AMEND	ED			
	Claims Remaining	Highest Number Previously Paid	Extra	Rate		
				Large	Small	Amount
Number of Claims (in excess of 20)	37	25	0	\$18.00	\$9.00	\$216.00
Independent Claims (in excess of 3)	0	0	0	\$84.00	\$42.00	-0-
Extension Fee: a) One Month				\$110.00	\$55.00	\$110.00
		-				
TOTAL FEE DUE:						

Method of Payment:

[XX] A check payable to the Commissioner of Patents and Trademarks, in the amount of \$326.00 is enclosed as payment of the Total Fee.

[] Please charge my Deposit Acc. 50-0763 in the amount of \$_____ to cover the above fees. A duplicate copy of this sheet is enclosed.

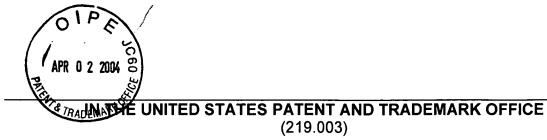
[XX] The Commissioner is hereby authorized to charge any fees that may be required, or credit any overpayment to Deposit Acc. 50-0763. A duplicate copy of this sheet is enclosed.

Date: March 30, 2004

Neil Steinberg Reg. No. 34,735

Respectfully submitted.

Telephone No. (650) 968-8079



In re Application of: YAMADA

Serial No: 09/865,528

U.S. Filing Date: MAY 28, 2001

Title: SEMICONDUCTOR DEVICE TEST METHOD AND SEMICONDUCTOR DEVICE TESTER

Croup Art Unit: 2829

Examiner: VINH P. NUGYEN

AND SEMICONDUCTOR DEVICE TESTER

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

AMENDMENT AND RESPONSE TO DECEMBER 3, 2003 OFFICE ACTION

Dear Sir:

Kindly amend the application as follows:

04/05/2004 WABRHAM1 00000061 09865528

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